Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/623,972	CHEN ET AL.	
Examiner	Art Unit	
PAUL V. WARD	1623	

	SEARCHED				
Class	Subclass	Date	Examiner		
544	256	5/12/2005	PVW		
514	262.1	5/12/2005	PVW		

INTERFERENCE SEARCHED				
Subclass	Date	Examiner		
Searched	5/12/2005	PVW		
	Subclass	Subclass Date		

SEARCH N (INCLUDING SEARC)
	DATE	EXMR
EAST	5/12/2005	PVW
INVENTOR SEARCH	5/12/2005	PVW
STN STRUCTURE SEARCH	5/12/2005	PVW